

FOREIGN PATENT DOCUMENTS

TRANSLATION						
DOCUMENT	DATE	COUNTRY	CLASS	SUBCLASS	YES	NO
10-260866 A	9-1998	JP			partial	
2000-222482 A	8-2000	JP			partial	
9-114907 A	5-1987	JP			partial	
2000-40062 A	2-2000	JP			partial	
2001-117448 A	4-2001	JP			partial	
2002-132992 A	5-2002	JP			partial	
10-154181 A	6-1998	JP			partial	
11-3005 A	1-1999	JP			partial	
2001-134149 A	5-2001	JP			partial	
2001-24838 A	1-2001	JP			partial	

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent pages, etc.)

Japanese Office Action mailed August 23, 2005 in corresponding Japanese patent application no. 2001-153080

Examiner

Date Considered

Examiner: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to application.

Form PTO-FB-A820 (Also PTO-1449)

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Form PTO-FB-A820 (Also PTO-1449)

INFORMATION DISCLOSURE			ATTY. DOCKET NO.	SERIAL NO.	
CITATION			1035-362	10/035,159	
			APPLICANT		
(Use several sheets if necessary)			YOSHIURA et al	GROUP	
NOV 7 2005 U.S. PATENT & TRADEMARK OFFICE JAPAN			FILING DATE		
January 4, 2002				2164	
U.S. PATENT DOCUMENTS					
EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS
FILING DATE IF APPROPRIATE					
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Examiner	Signature		Date Considered	12/13/06	

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